Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/622,467	CHOI, PIL HEON
Examiner	Art Unit
Quoc D. Tran	2614

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Class	Subclass	Date	Examiner
379	156	10/18/2005	QT
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Application/Control No.	Applicant(s)/Patent u Reexamination	Applicant(s)/Patent under Reexamination	
10/622,467	CHOI, PIL HEON		
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379	93.17	10/18/2005	QΤ
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